

# Silicon Carbide (SiC) Module – EliteSiC Power Module for OBC, 80 mohm, 1200 V, 20 A, Dual Half-Bridge, in APM32 Series NVXK2TR80WDT

#### **Features**

- DIP Silicon Carbide H–Bridge Power Module for On–board Charger (OBC) for xEV Applications
- Creepage and Clearance per IEC 60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, ROHS and UL94V-0 Compliant
- Automotive Qualified per AEC-Q101 and AQG324

#### **Typical Applications**

• DC-DC and On-Board Charger in xEV Applications

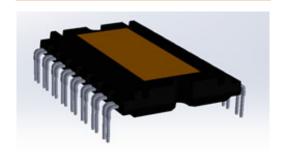
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	Drain-to-Source Voltage		1200	V
Gate-to-Source Voltage		$V_{GS}$	+25/-15	V
Recommended Operation Gate-to-Source Voltage,		$V_{GSop}$	+20/-5	V
Continuous Drain Current (Notes 1, 2)	T <sub>C</sub> = 25°C	I <sub>D</sub>	20	Α
Power Dissipation (Note 1)		P <sub>D</sub>	82	W
Pulsed Drain Current (Note 3)	T <sub>C</sub> = 25°C	I <sub>DM</sub>	110	Α
Single Pulse Surge Drain Current Capability	$T_{C} = 25^{\circ}C,$ $t_{p} = 10 \ \mu\text{s},$ $R_{G} = 4.7 \ \Omega$	I <sub>DSC</sub>	266	Α
Operating Junction Tempe	rature	$T_{J}$	-40 to 175	°C
Storage Temperature		T <sub>stg</sub>	-40 to 125	°C
Source Current (Body Diode) (Note 2)		I <sub>S</sub>	18	Α
Single Pulse Drain-to-Sou Avalanche Energy (Note 4)		E <sub>AS</sub>	180	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Particular conditions specified determine thermal resistance values shown. Infinite heatsink with  $T_C=100^{\circ}C$  for  $R_{\theta JC}$ . For  $R_{\Psi JS}$  assembled to 3 mm thick aluminum heatsink with infinite cooling bottom surface at 85°C, through 38  $\mu m$  thick TIM with 6.5 W/mK thermal conductivity.
- 2. Qualified per ECPE Guideline AQG 324.
- Repetitive rating limited by maximum junction temperature and transconductance.
- 4.  $E_{AS}$  based on initial  $T_J = 25^{\circ}C$ , L = 1 mH,  $I_{AS} = 19$  A,  $V_{DD} = 120$  V,  $V_{GS} = 18$  V.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
1200 V	116 m $\Omega$ @ 20 V	20 A



APM32



#### APM32 AUTOMOTIVE MODULE CASE MODHL

#### MARKING DIAGRAM

NVXK2TR80WDT ZZZ ATYWW NNNNNNN

NVXK2TR80WDT = Specific Device Code

ZZZ = Lot ID

AT = Assembly Site & Test Location

Y = Year W = Work Week NNN = Serial Number

#### **ORDERING INFORMATION**

Device	Package	Shipping
NVXK2TR80WDT	APM32 (Pb-Free)	10 ea / Tube

■ 4 – NC

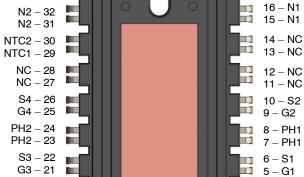
3 – NC

2 – P1

1 – P1

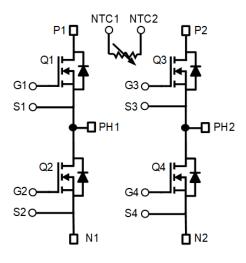
#### **PIN CONFIGURATION**

## The Contraction



APM32

#### INTERNAL EQUIVALENT CIRCUIT



SiC MOSFET H-Bridge Module

#### **PIN DESCRIPTION**

NC - 20

NC - 19

P2 - 18

P2 – 17

Pin	Name	Pin Description
1, 2	P1	Intermediate DC Bus Plus1
5	G1	SiC MOSFET Gate1
6	S1	SiC MOSFET Source1
7, 8	PH1	Phase Connection1
9	G2	SiC MOSFET Gate2
10	S2	SiC MOSFET Source2
15, 16	N1	Intermediate DC Bus Minus1
17, 18	P2	Intermediate DC Bus Plus2
21	G3	SiC MOSFET Gate3
22	S3	SiC MOSFET Source3
23, 24	PH2	Phase Connection2
25	G4	SiC MOSFET Gate4
26	S4	SiC MOSFET Source4
29	NTC1	Negative Temperature Coefficient Thermistor1
30	NTC2	Negative Temperature Coefficient Thermistor2
31, 32	N2	Intermediate DC Bus Minus2
3, 4, 11, 12, 13, 14, 19, 20, 27, 28	NC	Not Connected pin

#### THERMAL CHARACTERISTICS (Note 1)

Parameter	Symbol	Тур	Max	Unit
Thermal Resistance Junction-to-Case (Note 1)	$R_{ heta JC}$	1.41	1.84	°C/W
Thermal Resistance Junction-to-Sink (Note 1)	$R_{\PsiJS}$	1.84	2.26	°C/W

#### **ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Condi	tions	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		1200			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 1 mA, referenced	to 25°C		500		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			100	μΑ
		V <sub>DS</sub> = 1200 V	T <sub>J</sub> = 175°C			1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +25/-15 \text{ V}, V_{DS}$	s = 0 V			±1	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 5$ mA		1.8	3	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>			-5		+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 25°C		80	116	mΩ
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A	, T <sub>J</sub> = 175°C		150		mΩ
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 20 \text{ V}, I_D = 20 \text{ A}$			11		S
CHARGES, CAPACITANCES & GATE RES	ISTANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V			1154		pF
Output Capacitance	C <sub>OSS</sub>				79		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				7.9		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V},$ $I_D = 20 \text{ A}$			56		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				10		1
Gate-to-Source Charge	Q <sub>GS</sub>				18		1
Gate-to-Drain Charge	$Q_{GD}$				11		1
Gate-Resistance	R <sub>G</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz			1.2		Ω
INDUCTIVE SWITCHING CHARACTERIST	ics				•		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} =$			12		ns
Rise Time	t <sub>r</sub>	$I_D = 20 \text{ A}, R_G = 4.7 \Omega$ Inductive load	,		12		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	maddive lead			21		1
Fall Time	t <sub>f</sub>	1			9		1
Turn-On Switching Loss	E <sub>ON</sub>	1			135		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	1			46		μJ
Total Switching Loss	E <sub>tot</sub>	1			181		μJ
DRAIN-SOURCE DIODE CHARACTERIST		•			-		•
Continuous Drain-Source Diode Forward Current (Note 1)	I <sub>SD</sub>	$V_{GS} = -5 \text{ V}, T_{J} = 25^{\circ}\text{C}$	)			18	А
Pulsed Drain-Source Diode Forward Current (Note 3)	I <sub>SDM</sub>	$V_{GS} = -5 \text{ V}, T_{J} = 25^{\circ}\text{C}$				110	А
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = -5 \text{ V}, I_{SD} = 10 \text{ A}$	A T 0500		3.9		V

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5 \text{ V}, dI_S/dt = 1000 \text{ A}/\mu\text{s},$		16.2		ns
Peak Reverse Recovery Current	I <sub>RRM</sub>	I <sub>SD</sub> = 20 A		7.6		Α
Reverse Recovery Energy	E <sub>REC</sub>	1		4.1		μJ
Reverse Recovery Charge	Q <sub>RR</sub>			61.6		nC

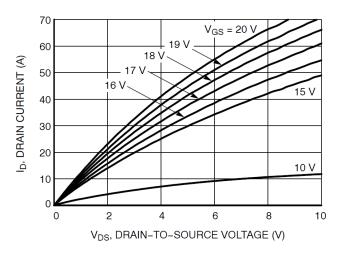
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse test: pulse width ≤300 µs, duty ratio ≤2%.

#### NTC THERMISTOR

Description	Туре	Quantity	Specification
10 kΩ, ±3%	Discrete	1	B Constants
Case Size 0603			B <sub>25/50</sub> : 3590
			B <sub>25/85</sub> = 3635
			B <sub>25/100</sub> = 3650 ±3%

#### **TYPICAL CHARACTERISTICS**



3.5 OL NOBWARIZED DRAIN CARENT (A)

3.5 OL NOBWARIZED DRAIN CURRENT (A)

VGS = 15 V

16 V

17 V

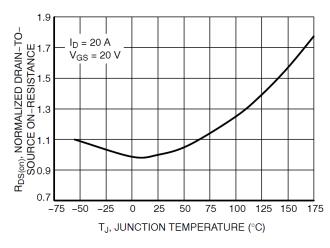
18 V

19 V

19 DRAIN CURRENT (A)

Figure 1. On-Region Characteristics

Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage



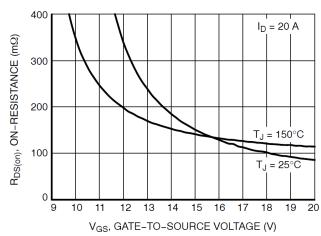
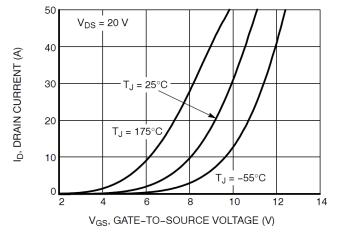


Figure 3. On–Resistance Variation with Temperature

Figure 4. On-Resistance vs. Gate-to-Source Voltage



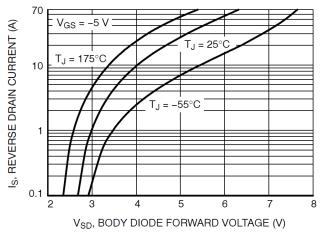


Figure 5. Transfer Characteristics

Figure 6. Diode Forward Voltage vs. Current

#### TYPICAL CHARACTERISTICS (CONTINUED)

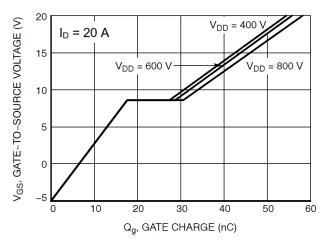


Figure 7. Gate-to-Source Voltage vs. Total Charge

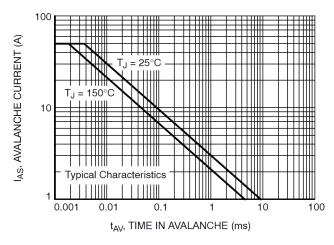


Figure 9. Unclamped Inductive Switching Capability

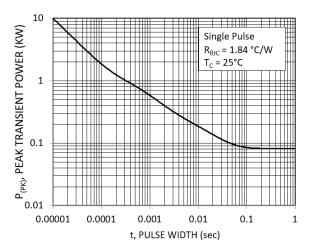


Figure 11. Single Pulse Maximum Power Dissipation

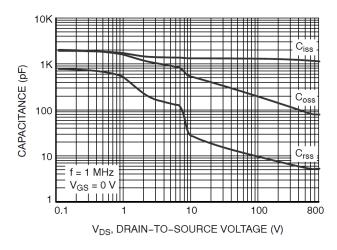


Figure 8. Capacitance vs. Drain-to-Source Voltage

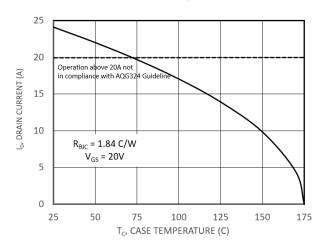


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

#### TYPICAL CHARACTERISTICS (CONTINUED)

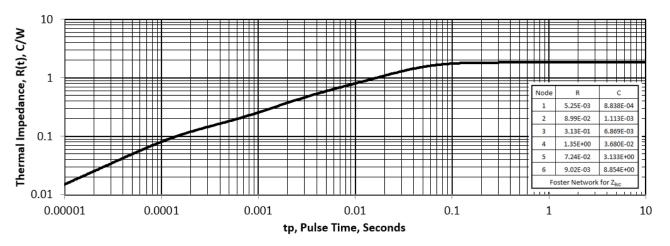
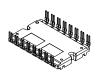


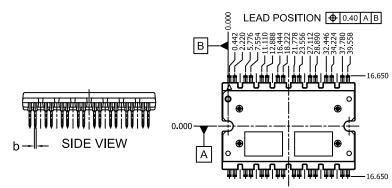
Figure 12. Thermal Response





# APM32 AUTOMOTIVE MODULE CASE MODHL ISSUE B

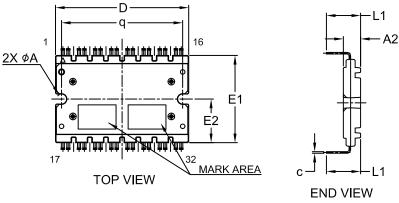
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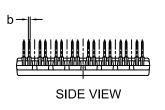


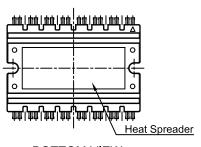
#### NOTES:

- DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS					
DIM	MIN.	NOM.	MAX.			
A2	5.60	5.70	5.80			
b	0.50	0.60	0.70			
С	0.45	0.50	0.60			
D	43.80	44.00	44.20			
E1	28.60	28.80	29.00			
E2	14.25	14.40	14.55			
L1	11.00	11.30	11.60			
q	39.85	40.00	40.15			
ØΑ	3.20	3.30	3.40			







**BOTTOM VIEW** 

### GENERIC MARKING DIAGRAM\*

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year W = Work Week

NNN = Serial Number

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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